


<b>Search Notes</b>  	<b>Application/Control No.</b>  10598337	<b>Applicant(s)/Patent Under Reexamination</b>  KIM ET AL.
	<b>Examiner</b>  EDWARD CHANG	<b>Art Unit</b>  3691

SEARCHED			
Class	Subclass	Date	Examiner
705	40	10/13/2008	EC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST -- Key word search	1/15/2010	EC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
705	40	10/13/2008	EC

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